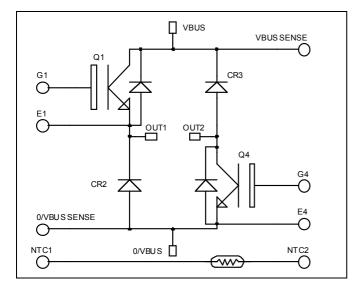


Asymmetrical - Bridge Fast Trench + Field Stop IGBT3 Power Module



### O VBUS 0 0 G4 fi OUT2 SENSE E4 🕻 VBUS 0/VBUS OUT1 🕯 E1 0/VBUS NTC2 SENSE # NTC1 8 0 0 Ğı D

# Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
Т	Continuous Collector Current	$T_C = 25^{\circ}C$	75	
I <sub>C</sub>	Continuous Conector Current	$T_C = 80^{\circ}C$	50	Α
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	277	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	100A @ 1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

# APTGT50DH120TG

# $V_{CES} = 1200V$ $I_{C} = 50A$ @ Tc = 80°C

### Application

- Welding converters
- Switched Mode Power Supplies
- Switched Reluctance Motor Drives

# Features

- Fast Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
  - Very low stray inductance
    - Symmetrical design
    - Lead frames for power connections
  - High level of integration
- Internal thermistor for temperature monitoring

### Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- Low profile
  - **RoHS** Compliant



# All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

# **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				250	μA
V	Collector Emitter Saturation Voltage	T T T T	$T_j = 25^{\circ}C$		1.7	2.1	V
V <sub>CE(sat)</sub>			$T_{j} = 125^{\circ}C$		2.0		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 2mA$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		3600		
Coes	Output Capacitance	$V_{CE} = 25V$		190		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz		160		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		90		
Tr	Rise Time	$V_{GE} = 15V$		30		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 50A$		420		ns
$T_{\rm f}$	Fall Time	$R_G = 18 \Omega$		70		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C)		90		
Tr	Rise Time	$V_{GE} = 15V$		50		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 50A$		520		ns
$T_{\rm f}$	Fall Time	$R_G = 18 \Omega$		90		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 600V$ $T_j = 125^{\circ}C$		5		mJ
E <sub>off</sub>	Turn-off Switching Energy	$\begin{bmatrix} I_{C} = 50A \\ R_{G} = 18 \Omega \end{bmatrix} T_{j} = 125^{\circ}C$		5.5		mJ

# Diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$ $T_i = 125^{\circ}C$			250 500	μΑ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		50		А
V <sub>F</sub>	Diode Forward Voltage	$I_F = 50A$	$T_i = 25^{\circ}C$ $T_i = 125^{\circ}C$		1.4 1.3	1.9	V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 50A$ $V_R = 600V$ di/dt = 2000A/µs	$T_j = 25^{\circ}C$ $T_i = 125^{\circ}C$		150 250		ns
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 25^{\circ}C$ $T_j = 125^{\circ}C$		4.5 9		μC
Er	Reverse Recovery Energy		$T_j = 25^{\circ}C$ $T_j = 125^{\circ}C$		2.1 4.2		mJ

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# APTGT50DH120TG

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K
-	P				

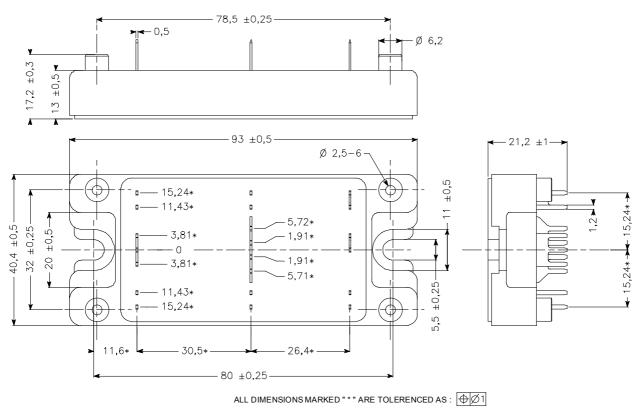
$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Therm  
R<sub>T</sub>: Therm

Thermistor temperature Thermistor value at T

# Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT Diode			0.45	°C/W
						0.58	$\mathcal{O}$ W
VISOL	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C	
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2.5		4.7	N.m
Wt	Package Weight					160	g

# SP4 Package outline (dimensions in mm)



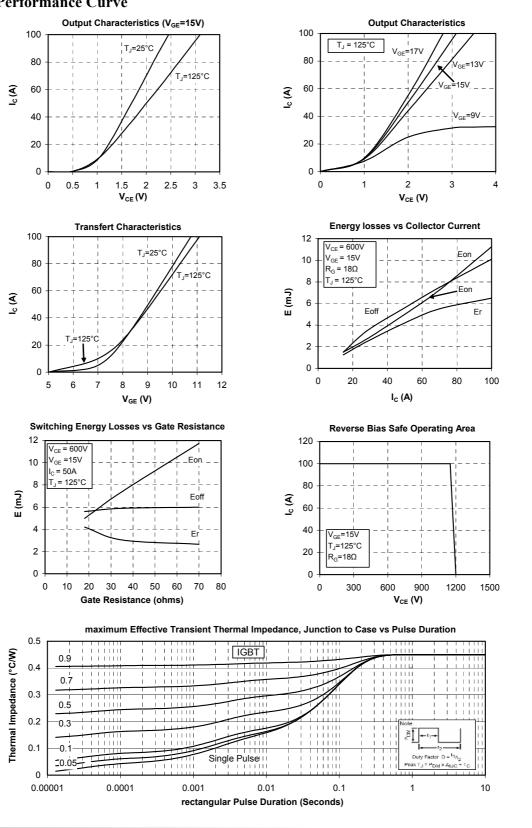
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com

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# **Typical Performance Curve**

# APTGT50DH120TG

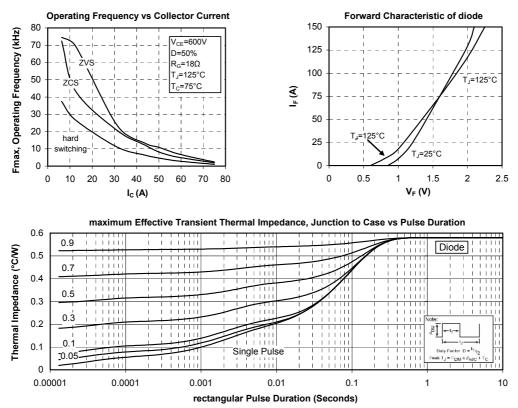


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